Applicant(s)/Patent Under Application/Control No. Reexamination 10/676,341 BENDEK ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 3763 Christopher D. Koharski **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-Α US-В С US-US-D US-E US-F US-G USн US-US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Name Country Country Code-Number-Kind Code MM-YYYY EP 937476 A2 08-1999 **European Patent** GIAMBATTISTA et al. A61M 5/315 Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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